

PNP SILICON POWER TRANSISTORS

D45H1A transistor is designed for use in low voltage and low drop-out regulator switching circuits application

FEATURES:

- * Collector-Emitter Voltage
- V_{CEO}= 15V(Min) * High Current Power Transistors
- * DC Current Gain
 - hFE= 70 (Min.)@I_c= 8.0A

MAXIMUM RATINGS

Characteristic	Symbol	D45H1A	Unit
Collector-Emitter Voltage	V _{CEO}	15	v
Collector-Base Voltage	V _{CBO}	20	v
Emitter-Base Voltage	V _{EBO}	5.0	v
Collector Current - Continuous - Peak	I _с I _{см}	10 20	A
Total Power Dissipation @T _c = 25°C Derate above 25°C	Po	60 0.48	w w/°c
Operating and Storage Junction Temperature Range	T _J ,T _{STG}	-55 to +150	°C

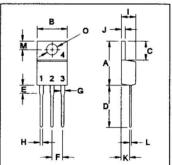


PNP

D45H1A

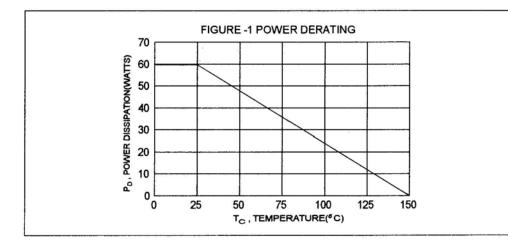






THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance Junction to Case	Rθjc	2.08	°C/W





DIM	MILLIMETERS			
DIM	MIN	MAX		
A	14.68	16.00		
В	9.78	10.42		
С	5.02	6.60		
D	13.00	14.62		
E	3.10	4.19		
F	2.41	2.67		
G	1.10	1.67		
н	0.69	1.01		
I	3.21	4.98		
J	1.14	1.40		
К	2.20	3.30		
L	0.28	0.61		
M	2.48	3.00		
0	3.50	4.00		

ELECTRICAL CHARACTERISTICS	$(T_c = 25^{\circ}C \text{ unless otherwise noted})$

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector-Emitter Voltage (I _C = 30 mA, I _B = 0)	V _{CEO}	15		v
Collector Cutoff Current (V _{CB} = 20 V, I _E = 0)	I _{сво}		10	uA
Emitter Cutoff Current (V _{EB} = 5.0 V, I _C = 0)	I _{EBO}		10	uA

ON CHARACTERISTICS (1)

DC Current Gain (I _c = 8.0 A, V _{CE} = 1.0 V)	hFE	70		
Collector-Emitter Saturation Voltage (I _C = 8.0 A, I _B = 400 mA)	V _{CE(sat)}		0.6	V
Base-Emitter Saturation Voltage (I _C = 8.0 A, I _B = 400 mA)	V _{BE(sat)}		1.5	V

(1) Pulse Test: Pulse Width =300 μ s,Duty Cycle \leq 2.0%:



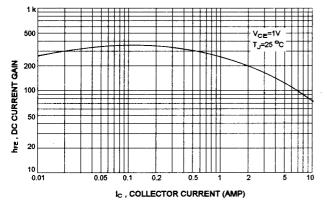


FIG-4 SAFE OPERATING AREA

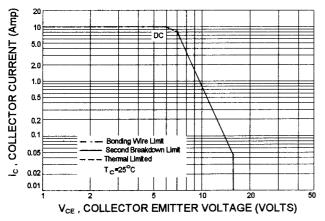
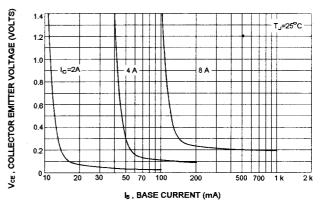


FIG-3 COLLECTOR SATURATION REGION



There are two limitation on the power handling ability of a transistor average junction temperature and second breakdown safe operating area curves indicate I_{C} - V_{CE} limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than curves indicate.

The data of FIG-4 is base on $T_{J(PK)}$ =150 °C;T_c is variable depending on power level.second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(PK)}$ <150°C,At high case temperatures, thermal limitation will reduce the power that can be handled to Values less than the limitations imposed by second breakdown.



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